## 2SK3380

### Silicon N Channel MOS FET High Speed Switching

# **HITACHI**

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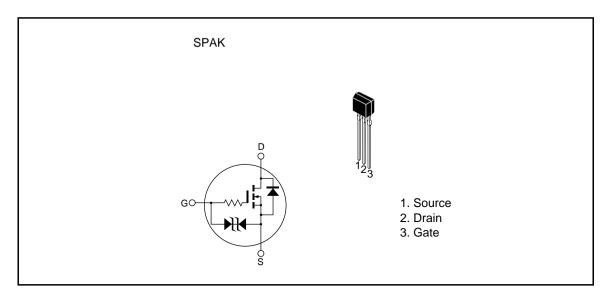
#### **Features**

Low on-resistance

$$R_{DS}$$
 =1.26  $\Omega$  typ. (V  $_{GS}$  = 10 V ,  $I_D$  = 150 mA) 
$$R_{DS}$$
 = 2.8  $\Omega$  typ. (V  $_{GS}$  = 4 V ,  $I_D$  = 50 mA)

4 V gate drive device.

#### Outline



### **Absolute Maximum Ratings (Ta = 25^{\circ}C)**

Item	Symbol	Ratings	Unit
Drain to source voltage	V <sub>DSS</sub>	30	V
Gate to source voltage	$V_{GSS}$	±20	V
Drain current	I <sub>D</sub>	300	mA
Drain peak current	I <sub>D(pulse)</sub> Note1	1.2	A
Body-drain diode reverse drain current	I <sub>DR</sub>	300	mA
Channel dissipation	Pch	300	mW
Channel temperature	Tch	150	°C
Storage temperature	Tstg	-55 to +150	°C

Note:  $1.PW \le 10 \mu s$ , duty cycle  $\le 1\%$ 

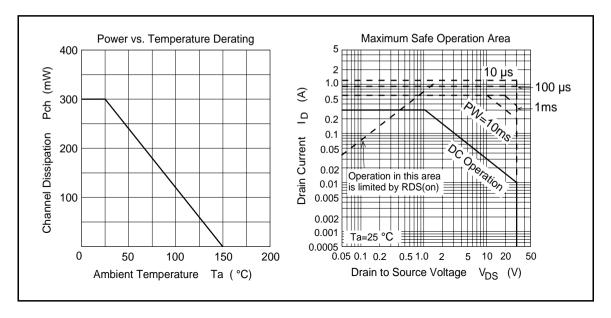
### Electrical Characteristics ( $Ta = 25^{\circ}C$ )

Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	V <sub>(BR)DSS</sub>	30	_	_	V	$I_D = 100 \ \mu\text{A}, \ V_{GS} = 0$
Gate to source breakdown voltage	V <sub>(BR)GSS</sub>	±20	_	_	V	$I_G = \pm 100 \ \mu A, \ V_{DS} = 0$
Gate to source leak current	I <sub>GSS</sub>	_	_	±5	μΑ	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0$
Zero gate voltege drain current	I <sub>DSS</sub>	_	_	1	μΑ	$V_{DS} = 30 \text{ V}, V_{GS} = 0$
Gate to source cutoff voltage	V <sub>GS(off)</sub>	1.3	_	2.3	V	$I_D = 10\mu A, V_{DS} = 5 V$
Static drain to source on state resistance		_	1.26	1.44	Ω	I <sub>D</sub> = 150 mA,V <sub>GS</sub> = 10 V Note 2
	R <sub>DS(on)</sub>	_	2.8	3.44	Ω	$I_D = 50 \text{ mA}, V_{GS} = 4 \text{ V}^{\text{Note}}$
Forward transfer admittance	y <sub>fs</sub>	145	220	_	mS	I <sub>D</sub> = 150 mA, V <sub>DS</sub> =10 V Note 2
Input capacitance	Ciss	_	6	_	pF	V <sub>DS</sub> = 10 V
Output capacitance	Coss	_	18	_	pF	V <sub>GS</sub> = 0
Reverse transfer capacitance	Crss	_	2	_	pF	f = 1 MHz
Turn-on delay time	t <sub>d(on)</sub>	_	200	_	ns	$I_D = 150 \text{ mA}, V_{GS} = 10 \text{ V}$
Rise time	t <sub>r</sub>		600		ns	$R_L = 66.6 \Omega$
Turn-off delay time	t <sub>d(off)</sub>	_	1100	_	ns	
Fall time	t <sub>f</sub>	_	1100	_	ns	

Note: 2.Pulse test

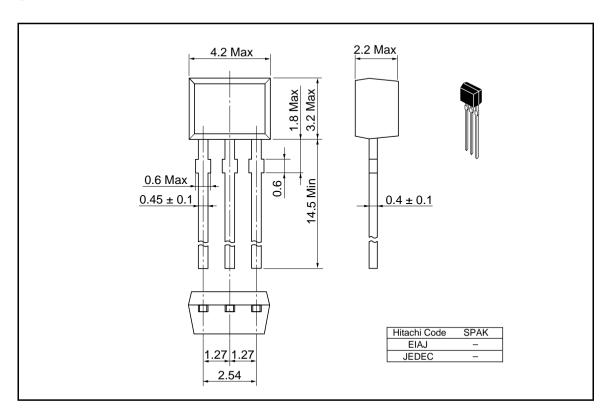
See characteristics curves of 2SK3288

#### **Main Characteristics**



### **Package Dimensions**

Unit: mm



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